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ICS 77.040
CCS H 17

NATIONAL STANDARD OF THE PEOPLE'S REPUBLIC OF CHINA

GB/T 34504-2017

Measurement method for surface metal contamination on sapphire polished substrate wafer

蓝宝石抛光衬底片表面残留金属元素测量方法

(English Translation)

Issued on: October 14, 2017 **Implemented on: May 1, 2018**

Issued by: General Administration of Quality Supervision, Inspection and Quarantine of the People's Republic of China, Standardization Administration of the People's Republic of China

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Document data

International classification (ICS): 77.040.

Chinese classification (CCS): H17.

Estimated length of the Chinese original: 14,138 words.

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